



General Description

These P-Channel enhancement mode power field effect transistors are using trench DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency fast switching applications.

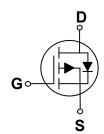
| BV _{DSS} | R _{DS(ON)} | Ι _D |
|-------------------|---------------------|----------------|
| -30 V | 55 mΩ | -4.1 A |

Features

- $R_{DS(ON)} \le 55 m\Omega @V_{GS} = -10V$
- Exceptional On-Resistance and Maximum DC Current Capability
- Super High Density Cell Design for Extremely Low R_{DS(ON)}

SOT-23 Pin Configuration





Applications

- · Portable equipment
- Battery Powered System
- · Power Management in Note
- Load Switch

| Symbol | Symbol Parameter | | Units | |
|------------------|---|------------|-------|--|
| V_{DS} | Drain-Source Voltage | -30 | V | |
| V_{GS} | Gate-Source Voltage | ±20 | V | |
| I _D | Drain Current - Continuous (T _A =25°C) | -4.1 | Α | |
| I _{DM} | Drain Current - Pulsed | -16.4 | Α | |
| P_{D} | Power Dissipation (T _A =25°C) | 1.56 | W | |
| T_J | Operating Junction Temperature Range | -50 to 150 | °C | |
| T _{STG} | Storage Temperature Range | -50 to 150 | °C | |

| Thermal Characteristics | | | | | |
|-------------------------|--|--------|------|--|--|
| Symbol | Parameter | Rating | Unit | | |
| $R_{\theta JA}$ | Thermal Resistance Junction to Ambient | 80 | °C/W | | |





Electrical Characteristics (T_J=25°C, unless otherwise noted)

Off Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|-------------------|--------------------------------|--|------|------|------|------|
| BV _{DSS} | Drain-Source Breakdown Voltage | V _{GS} = 0V , I _D = -250uA | -30 | | | V |
| I _{DSS} | Drain-Source Leakage Current | V_{DS} = -30V , V_{GS} = 0V | | | -1 | uA |
| I _{GSS} | Gate-Source Leakage Current | V_{GS} = ±20V , V_{DS} = 0V | | | ±100 | nA |

On Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|---------------------|------------------------------------|--|------|------|------|-------|
| R _{DS(ON)} | IStatic Drain-Source On-Resistance | V_{GS} = -10V , I_D = -3A | | | 55 | mΩ |
| | | V _{GS} = -4.5V , I _D = -2A | | | 85 | 11122 |
| $V_{GS(th)}$ | Gate Threshold Voltage | $V_{GS}=V_{DS}$, $I_D=-250uA$ | -1.0 | | -2.5 | V |

Dynamic and switching Characteristics

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|--------------------|------------------------------|--|------|------|------|------|
| Q_g | Total Gate Charge | V _{DS} = -15V , V _{GS} = -4.5V , | | 5.1 | | |
| Q_{gs} | Gate-Source Charge | I _D = -3A | | 2.0 | | nC |
| Q_{gd} | Gate-Drain Charge | (NOTE 2) | | 2.2 | | i |
| T _{d(on)} | Turn-On Delay Time | V 45V V 40V | | 8.7 | | |
| T _r | Rise Time | V_{DS} = -15V , V_{GS} = -10V , - R_{G} = 6Ω , I_{D} = -1A | | 35.9 | | nS |
| $T_{d(off)}$ | Turn-Off Delay Time | | | 23 | | 113 |
| T_f | Fall Time | (11012) | | 8.5 | | |
| C _{iss} | Input Capacitance | | | 545 | | |
| C _{oss} | Output Capacitance | V_{DS} = -15V , V_{GS} = 0V , F= 1MHz | | 62.5 | | pF |
| C_{rss} | Reverse Transfer Capacitance | | | 48 | | |

Drain-Source Diode Characteristics and Ratings

| Symbol | Parameter | Conditions | Min. | Тур. | Max. | Unit |
|----------|--------------------------------|--|------|------|------|------|
| Is | Continuous Current | V _G =V _D =0V , Force Current | | | -4.1 | Α |
| V_{SD} | Diode Forward Voltage (NOTE 1) | V _{GS} = 0V , I _S = -1A | | | -1.2 | V |

NOTES:

- 1. The data tested by pulsed , pulse width \leq 300us , duty cycle \leq 2%.
- 2. Independent of operating temperature.
- 3. Pulsed width limited by maximum junction temperature.





Characteristics Curves

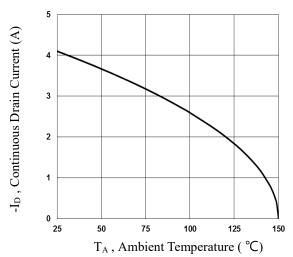


Fig.1 Continuous Drain Current vs. Tc

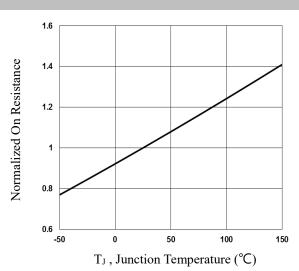


Fig.2 Normalized RDSON vs. TJ

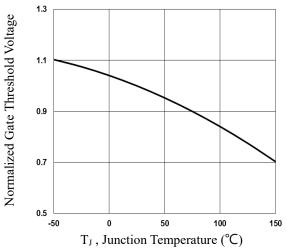


Fig.3 Normalized V_{th} vs. T_J

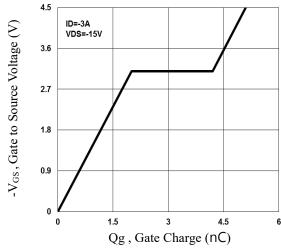


Fig.4 Gate Charge Waveform

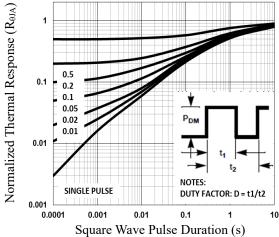


Fig.5 Normalized Transient Impedance

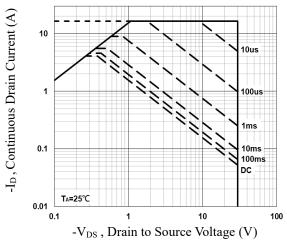
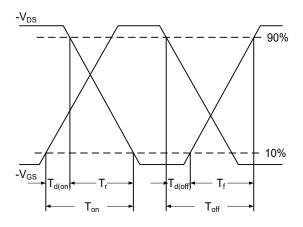


Fig.6 Maximum Safe Operation Area





Characteristics Curves





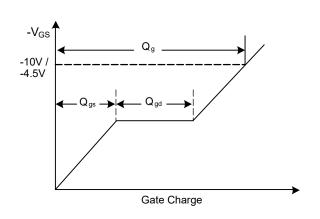
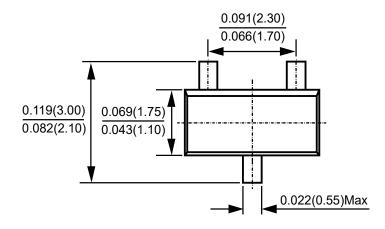
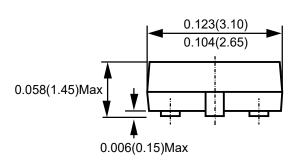
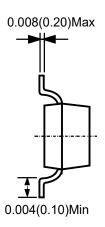


Fig.8 Gate Charge Waveform

Package Outline Dimensions







SOT-23 Dimensions in inches and (millimeters)





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